

LIST OF RELATED CASES

Examiner
Initial

LN

LN

<u>Docket Number</u>	<u>Serial or Patent No.</u>	<u>Filing or Issue Date</u>	<u>Status or Patentee</u>
0557-3248-2	5,436,657	07/25/95	FUKUOKA
0557-3542-2	6,104,430	08/15/00	FUKUOKA
0557-3982-2 REISSUE	RE 36,338	10/12/99	FUKUOKA
0557-4282-2 CONT	5,960,155	09/28/99	FUKUOKA et al.
0557-4783-2*	09/418,503	10/15/99	PENDING
200224US2 DIV	09/722,325	11/28/00	PENDING •

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TC 2800 MAIL ROOM

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Examiner: *Leonahurana Nauen* Date: *12/6/04*

*Present application; listed for information.



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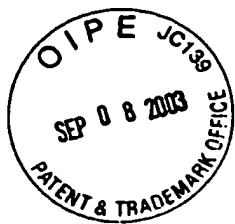
LIST OF RELATED CASES

<u>Examiner Initial</u>	<u>Docket Number</u>	<u>Serial or Patent No.</u>	<u>Filing or Issue Date</u>	<u>Status</u> Technology Center 2600 <u>or Patentee</u>
LN	0557-4783-2*	09/418,503	10/15/99	PENDING
LN	203441US2 DIV	09/790,664	02/23/01	PENDING

Examiner = *Lunahuna Naeuen*

date *12/6/04*

*Present application; listed for information
GJM/ae



LIST OF RELATED CASES

<u>Examiner Initial</u>	<u>Docket Number</u>	<u>Serial or Patent Number</u>	<u>Filing or Issue Date</u>	<u>Inventor/ Applicant</u>
LN	0557-4783-3*	09/418,503	10/15/99	YAMADA et al.
LN	238386US3	10/458,229	06/11/03	OKUDA °

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Examiner: *Leonahuna Naluen*

Date: 12/6/04

*Present Application; listed for information

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(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

0557-4783-2

SERIAL NO.

09/418,503

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

HIROHISA YAMADA, ET AL.

FILING DATE

OCTOBER 15, 1999

GROUP

2612

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
LN	AA	5,960,155	9/28/99	FUKUOKA			
	AB	Re: 36,338	10/12/99	FUJUOKA			
	AC	6,104,430	8/15/00	FUKUOKA			
LN	AD	5,436,657	7/25/95	FUKUOKA			
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AO					
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW		
	AX		
	AY		
	AZ		

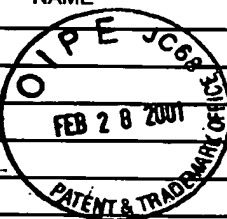
Examiner

Lusnahman Veeuen

Date Considered

12/06/04

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



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